

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/781,941	ASANO ET AL.		
Examiner	Art Unit		
Jeffrey S. Zweizig	2816		

SEARCHED						
Class		Subclass	Date		Examiner	
3:	327 309 3/3/3		2005	JZ		
		314 318				
		319 320				
		324 325				
		326 327				
		328 333			\cdot	
		564 565				
V		566	V		V	
update		above	5/25/05		JZ	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
			DATE	EXMR		
	EAST		3/3/2005	JZ		
L #	Hits	Searc	h Text			
Ն1	107833	electrostatic				
L2	2162	electro adj st	tatic			
L3	108770	1 or 2				
L4	418697	discharge				
L5	6887	3 adj 4	3 adj 4			
L6	field adj effect ad transistor					
L 7	40309	fet]			
ւ8	65151	6 or 7				
L9	1095	5 and 8	¥			

	INTERFERENCE SEARCHED				
	Class	Subclass	Date	Examiner	
	327	318	5/25/05	JZ	
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